

	Type	L #	Hits	Search Text	DBs	Time Stamp
1	BRS	L1	58	(electron\$1 adj10 beams) and (conver\$7 adj30 lens\$3) and (coat\$5 adj30 lens\$3)	US- PGPUB; USPAT; EPO; JPO; DERWEN T; IBM_TD B	2006/10/15 18:49
2	BRS	L2	17	(electron\$1 adj10 beams) and (conver\$7 adj30 lens\$3) and (coat\$5 adj30 lens\$3) and ((inspect\$5 or test\$5) adj10 (sample\$1 or wafer\$1))	US- PGPUB; USPAT; EPO; JPO; DERWEN T; IBM_TD B	2006/10/15 19:49
3	BRS	L3	1	(electron\$1 adj10 beams) and (deflect\$5 adj30 ferromagnetic adj30 magnet\$1) and ((inspect\$5 or test\$5) adj10 (sample\$1 or wafer\$1))	US- PGPUB; USPAT; EPO; JPO; DERWEN T; IBM_TD B	2006/10/15 19:50
4	BRS	L4	20	(electron\$1 adj10 beams) and (separat\$5 adj30 electrostatic adj30 electromagnetic) and ((inspect\$5 or test\$5) adj10 (sample\$1 or wafer\$1))	US- PGPUB; USPAT; EPO; JPO; DERWEN T; IBM_TD B	2006/10/15 19:51

	Type	L #	Hits	Search Text	DBs	Time Stamp
5	BRS	L5	0	((electron\$1 adj10 beams) and (conver\$7 adj30 lens\$3) and (coat\$5 adj30 lens\$3) and ((inspect\$5 or test\$5) adj10 (sample\$1 or wafer\$1))).clm.	US- PGPUB; USPAT; EPO; JPO; DERWEN T; IBM_TD B	2006/10/15 19:49
6	BRS	L6	0	((electron\$1 adj10 beams) and (deflect\$5 adj30 ferromagnetic adj30 magnet\$1) and ((inspect\$5 or test\$5) adj10 (sample\$1 or wafer\$1))).clm.	US- PGPUB; USPAT; EPO; JPO; DERWEN T; IBM_TD B	2006/10/15 19:50
7	BRS	L7	2	((electron\$1 adj10 beams) and (separat\$5 adj30 electrostatic adj30 electromagnetic) and ((inspect\$5 or test\$5) adj10 (sample\$1 or wafer\$1))).clm.	US- PGPUB; USPAT; EPO; JPO; DERWEN T; IBM_TD B	2006/10/15 19:51